

Notice of References Cited	Application/Control No. 10/602,848	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner W. Patty Chen	Art Unit 2871	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,781,253	07-1998	Koike et al.	349/40
*	B	US-5,019,001	05-1991	Abe et al.	445/3
*	C	US-6,211,534	04-2001	Matsumoto, Seiichi	257/59
*	D	US-5,444,022	08-1995	Gardner, Donald S.	438/627
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	K	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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